

Search Notes

Application/Control No.

09/634,339

Examiner

Maikhanh Nguyen

Applicant(s)/Patent under
Reexamination

KAYE, EVAN JOHN

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	501.1 500.1 514 526	10/4/2006	MK
709	200 202 203	10/4/2006	MK
707	3, 6 102	10/4/2006	MK
84	609 649	10/4/2006	MK
84	668	10/4/2006	MK
Updated	Search	10/11/2007	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	501.1 513	10/11/2007	MK
707	6	10/11/2007	MK
709	203	10/11/2007	MK
84	609	10/11/2007	MK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	10/3/2006	MK
NPL (ACM)	10/3/2006	MK
West Search (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	10/4/2006	MK
Consulted with William Bashore	10/10/2007	MK
West Search (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	10/11/2007	MK
Interference Search - See Search History Printout	10/11/2007	MK
NPL (IEEE & ACM) See Search History Printout	10/11/2007	MK